

# ${\color{red}{\text{CAS300M17BM2}}}$ 1.7kV, 8.0 m $\Omega$ All-Silicon Carbide Half-Bridge Module

C2M MOSFET and Z-Rec<sup>TM</sup> Diode

 $V_{DS}$  1.7 kV  $E_{sw, Total @ 300A, 150 °C}$  23 mJ  $R_{DS(on)}$  8.0 mΩ

#### **Features**

- Ultra Low Loss
- High-Frequency Operation
- Zero Reverse Recovery Current from Diode
- Zero Turn-off Tail Current from MOSFET
- Normally-off, Fail-safe Device Operation
- Ease of Paralleling
- Copper Baseplate and Aluminum Nitride Insulator

#### **System Benefits**

- Enables Compact and Lightweight Systems
- High Efficiency Operation
- Mitigates Over-voltage Protection
- Reduced Thermal Requirements
- Reduced System Cost

#### **Applications**

- HF Resonant Converters/Inverters
- Solar and Wind Inverters
- UPS and SMPS
- Motor Drive
- Traction

## Package 62mm x 106mm x 30mm



Part Number	Package	Marking
CAS300M17BM2	Half-Bridge Module	CAS300M17BM2

#### Maximum Ratings ( $T_c = 25$ °C unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Notes	
V <sub>DSmax</sub>	Drain - Source Voltage	1.7	kV			
$V_{\sf GSmax}$	Gate - Source Voltage	-10/+25	V	Absolute maximum values		
V <sub>GSop</sub>	Gate - Source Voltage	-5/20	V	Recommended operational values		
т .	Continuous MOSFET Drain Current	325	A	$V_{GS} = 20 \text{ V, } T_{C} = 25 \text{ °C}$	Fig. 26	
$I_{\scriptscriptstyle D}$	Continuous MOSFET Drain Current	225	A	$V_{GS} = 20 \text{ V, } T_{C} = 90 \text{ °C}$	Fig. 26	
I <sub>D(pulse)</sub>	Pulsed Drain Current	900	Α	Pulse width tp limited by $T_{J(max)}$		
	556		$V_{GS} = -5 \text{ V}, T_{C} = 25 \text{ °C}$			
I <sub>F</sub>	Continuous Diode Forward Current	353	Α	$V_{GS} = -5 \text{ V, } T_{C} = 90 ^{\circ}\text{C}$		
T <sub>Jmax</sub>	Junction Temperature	-40 to +150	°C			
T <sub>c</sub> ,T <sub>stg</sub>	Case and Storage Temperature Range	-40 to +125	°C			
V <sub>isol</sub>	Case Isolation Voltage	5.0	kV	AC, 50 Hz , 1 min		
L <sub>Stray</sub>	Stray Inductance	15	nH	Measured between terminals 2 and 3		
P <sub>D</sub>	Power Dissipation	1760	W	T <sub>C</sub> = 25 °C, T <sub>J</sub> = 150 °C	Fig. 25	



### Electrical Characteristics ( $T_c = 25$ °C unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
$V_{DSS}$	Drain - Source Blocking Voltage	1.7			kV	$V_{GS_r} = 0$ , $I_D = 2$ mA	
$V_{GS(th)}$	Gate Threshold Voltage	1.8	2.5		V	$V_D = V_{G}$ , $I_D = 15$ mA	Fig. 7
т	Zana Cata Valta sa Duain Cumunt		700	2000	μΑ	$V_{DS} = 1.7 \text{ kV, } V_{GS} = 0$	
$I_{DSS}$	Zero Gate Voltage Drain Current		1500	4000	μΑ	$V_{DS} = 1.7 \text{ kV,} V_{GS} = 0, T_{J} = 150 ^{\circ}\text{C}$	
$I_{GSS}$	Gate-Source Leakage Current		1	600	nA	$V_{GS} = 25 \text{ V, } V_{DS} = 0$	
В	On State Resistance		8.0	10	mΩ	$V_{GS} = 20 \text{ V, } I_{DS} = 300 \text{ A}$	Fig. 4, 5, 6
$R_{DS(on)}$			16.2	20		$V_{GS} = 20V, I_{DS} = 300 \text{ A,T}_{J} = 150 ^{\circ}\text{C}$	
a.	Transconductance		133		S	$V_{DS} = 20 \text{ V}, I_{DS} = 300 \text{ A}$	Fig. 8
<b>G</b> fs	Transconductance		131		]	$V_{DS} = 20 \text{ V}, I_{D} = 300 \text{ A}, T_{J} = 150 ^{\circ}\text{C}$	
$C_{iss}$	Input Capacitance		20				
$C_{oss}$	Output Capacitance		2.5		nF	$V_{DS} = 1 \text{ kV, } f = 200 \text{ kHz,}$ $V_{AC} = 25 \text{ mV}$	Fig. 16, 17
$C_{rss}$	Reverse Transfer Capacitance		0.08			170 - 2 1111	
E <sub>on</sub>	Turn-On Switching Energy		13.0		mJ	$V_{DD} = 900 \text{ V}, V_{GS} = -5\text{V}/+20\text{V}$ $I_D = 300 \text{ A}, R_{G(ext)} = 2.5 \Omega$	Fig. 22
E <sub>Off</sub>	Turn-Off Switching Energy		10.0		mJ	Load = 77 $\mu$ H, T <sub>1</sub> = 150 °C Note: IEC 60747-8-4 Definitions	
R <sub>G (int)</sub>	Internal Gate Resistance		3.7		Ω	f = 1 MHz, V <sub>AC</sub> = 25 mV	
$Q_{\text{GS}}$	Gate-Source Charge		273				Fig. 15
$Q_{GD}$	Gate-Drain Charge		324		nC	$V_{DD}$ = 900 V, $V_{GS}$ = -5V/+20V, $I_{D}$ = 300 A, Per JEDEC24 pg 27	
$Q_{G}$	Total Gate Charge		1076				
$t_{d(on)}$	Turn-on delay time		105		ns	$V_{DD} = 900V, V_{GS} = -5/+20V,$	Fig. 23
t <sub>r</sub>	Rise Time		72		ns	$I_D = 300 \text{ A}, R_{G(ext)} = 2.5 \Omega,$	
t <sub>d(off)</sub>	Turn-off delay time		211		ns	Timing relative to V <sub>DS</sub> Note: IEC 60747-8-4, pg 83	
t <sub>f</sub>	Fall Time		56		ns	Inductive load	
	Diede Femand Veltere		1.7	2.0	V	$I_F = 300 \text{ A, V}_{GS} = 0$	Fig. 10
$V_{SD}$	Diode Forward Voltage		2.2	2.5	]	$I_F = 300 \text{ A, V}_{GS} = 0 \text{ , T}_J = 150  ^{\circ}\text{C}$	Fig. 11
Qc	Total Capacitive Charge		4.4		μC	$I_{SD} = 300 \text{ A}, V_{DS} = 900 \text{ V}, T_{J} = 25^{\circ}\text{C}, di_{SD}/dt = 9 \text{ kA/}\mu\text{s}, V_{GS} = -5 \text{ V}$	

#### **Thermal Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
$R_{thJCM}$	Thermal Resistance Juction-to-Case for MOSFET		0.067	0.071	° 0 // //		Fig. 27
$R_{\text{thJCD}}$	Thermal Resistance Juction-to-Case for Diode		0.060	0.065	°C/W		Fig. 28

#### **Additional Module Data**

Symbol	Parameter	Max.	Unit	Test Condtion
W	Weight	300	g	
М	Mounting Torque	5	Nm	To heatsink and terminals
	Clearance Distance	9	mm	Terminal to terminal
	Creepage Distance	30	mm	Terminal to terminal
		40	mm	Terminal to baseplate



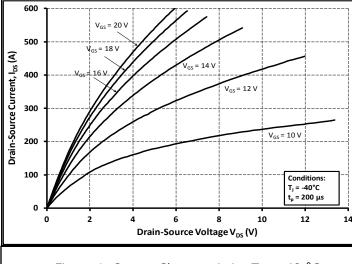


Figure 1. Output Characteristics  $T_{\text{\tiny J}}$  = -40 °C

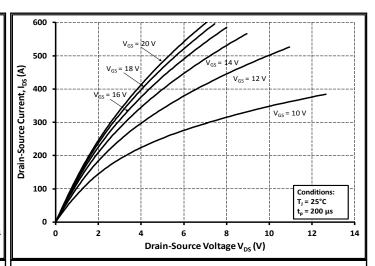


Figure 2. Output Characteristics  $T_1 = 25$  °C

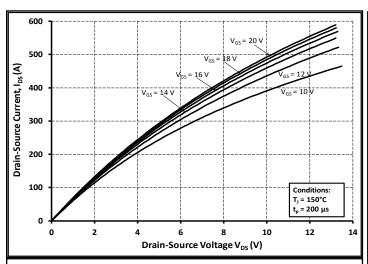


Figure 3. Output Characteristics  $T_1 = 150 \, ^{\circ}\text{C}$ 

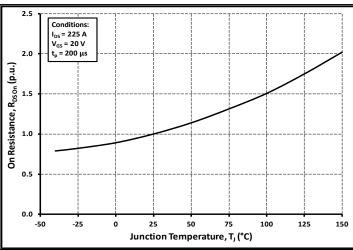


Figure 4. Normalized On-Resistance vs. Temperature

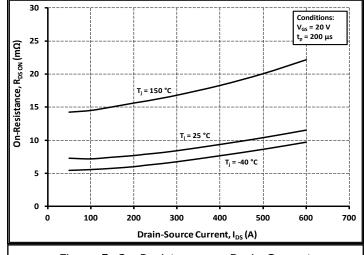


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

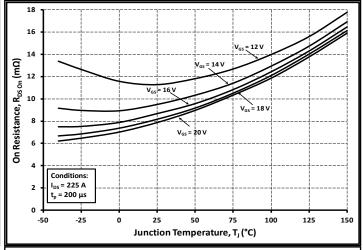
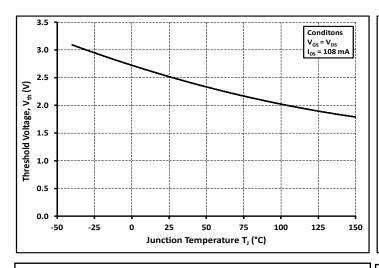


Figure 6. On-Resistance vs. Temperature for Various Gate-Source Voltage





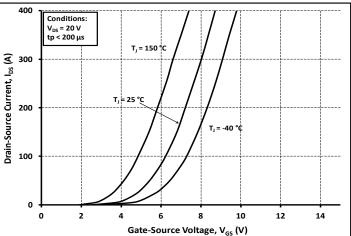
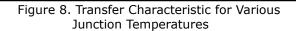
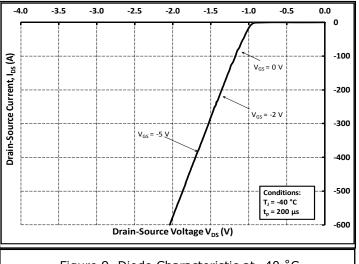


Figure 7. Threshold Voltage vs. Temperature







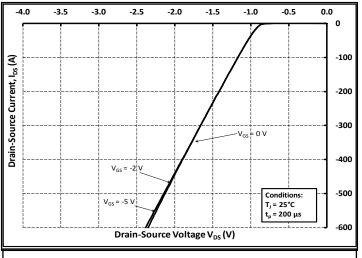
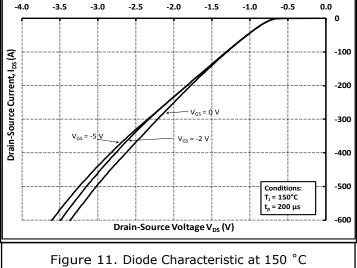


Figure 10. Diode Characteristic at 25 °C



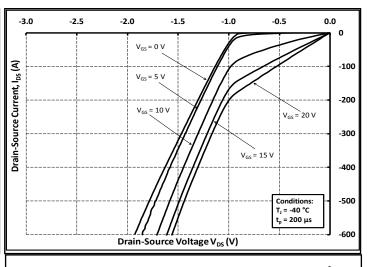


Figure 12. 3rd Quadrant Characteristic at -40 °C



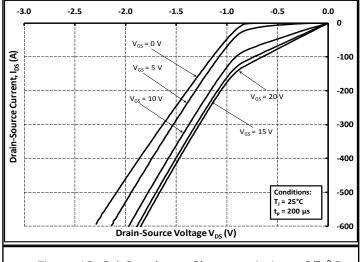


Figure 13. 3<sup>rd</sup> Quadrant Characteristic at 25 °C

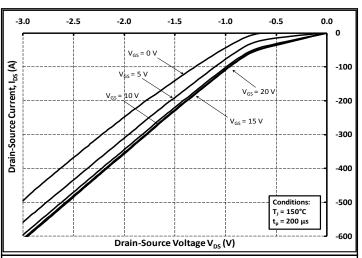


Figure 14. 3rd Quadrant Characteristic at 150 °C

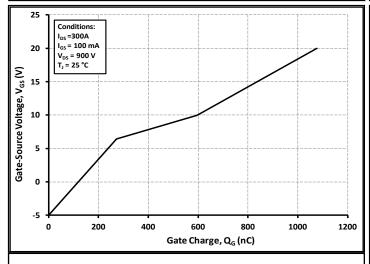


Figure 15. Gate Charge Characteristics

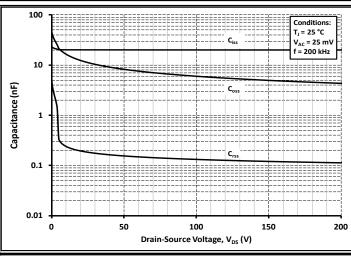


Figure 16. Capacitances vs. Drain-Source Voltage (0 - 200 V)

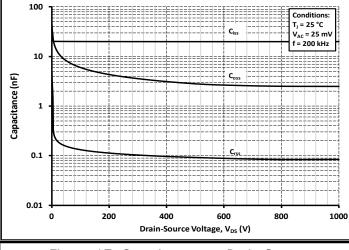


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 1 kV)

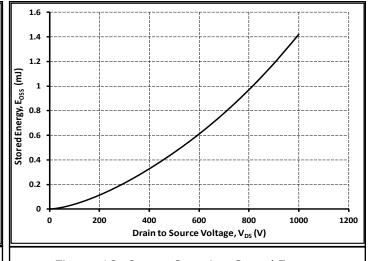


Figure 18. Output Capacitor Stored Energy



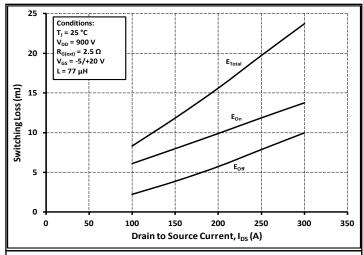


Figure 19. Inductive Switching Energy vs. Drain Current For  $\rm V_{DS}$  = 900V,  $\rm R_{\rm G}$  = 2.5  $\Omega$ 

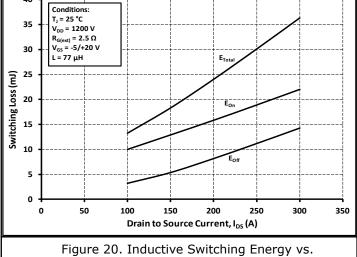


Figure 20. Inductive Switching Energy vs. Drain Current For  $V_{DS} = 1200 \text{ V}$ ,  $R_{G} = 2.5 \Omega$ 

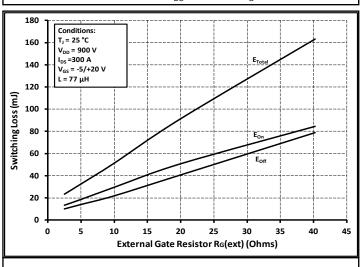


Figure 21. Inductive Switching Energy vs.  $R_{G(ext)}$ 

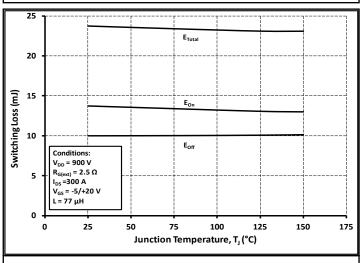


Figure 22. Inductive Switching Energy vs. Temperature

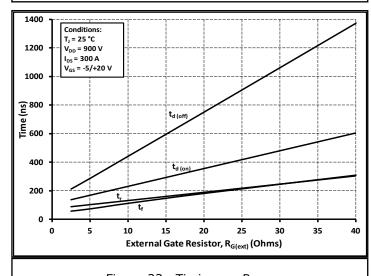


Figure 23. Timing vs.  $R_{G(ext)}$ 

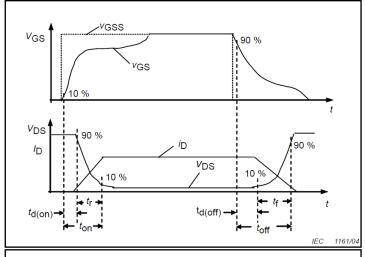


Figure 24. Resistive Switching Time Description



#### 2000 Conditions: T<sub>1</sub> ≤ 150 °C 1800 Maximum Dissipated Power, P<sub>tot</sub> (W 1600 1400 1200 1000 800 600 400 200 -20 60 80 100 120 140 20 40 -40 Case Temperature, T<sub>C</sub> (°C)

Figure 25. Maximum Power Dissipation (MOSFET) Derating vs. Case Temperature

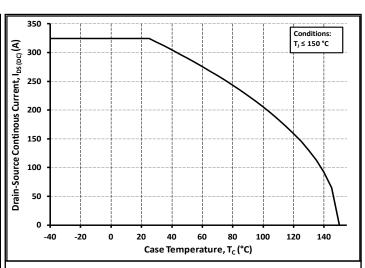


Figure 26. Continous Drain Current Derating vs Case Temperature

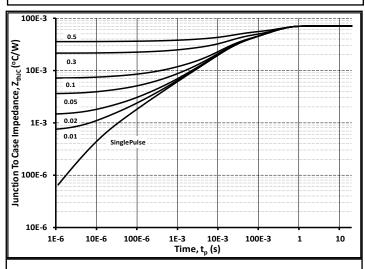


Figure 27. MOSFET Junction to Case Thermal Impedance

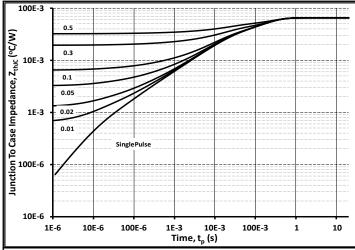


Figure 28. Diode Junction to Case Thermal Impedance

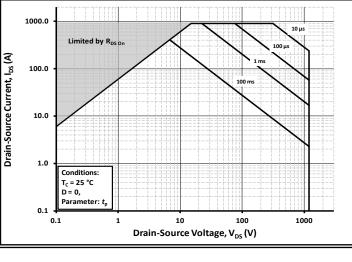
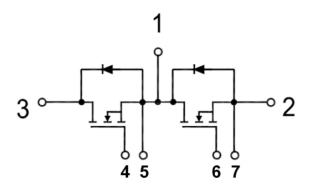
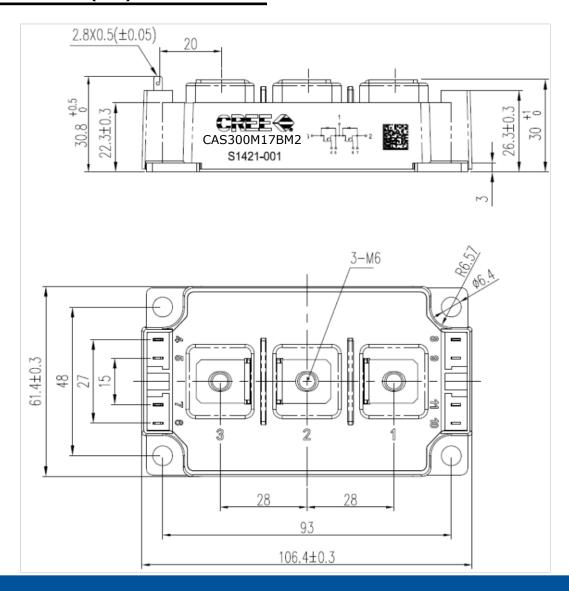


Figure 29. Safe Operating Area





#### Package Dimensions (mm)





#### **Notes**

#### RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your Cree representative or from the Product Documentation sections of www.cree.com.

#### REACh Compliance

REACh substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a Cree representative to insure you get the most up-to-date REACh SVHC Declaration. REACh banned substance information (REACh Article 67) is also available upon request.

• This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, air traffic control systems.

#### **Module Application Note:**

The SiC MOSFET module switches at speeds beyond what is customarily associated with IGBT based modules. Therefore, special precautions are required to realize the best performance. The interconnection between the gate driver and module housing needs to be as short as possible. This will afford the best switching time and avoid the potential for device oscillation. Also, great care is required to insure minimum inductance between the module and link capacitors to avoid excessive  $V_{\rm DS}$  overshoots.

Please Refer to application note: Design Considerations when using Cree SiC Modules Part 1 and Part 2. [CPWR-AN12, CPWR-AN13]